

Search Notes

Application/Control No.

10/643,801

Examiner

Jon B. Ashen

Applicant(s)/Patent under
Reexamination

BHANOT ET AL.

Art Unit

1635

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC: Score over Length, SEQ ID NO: 4, see scanned results	8/8/2005	JBA
EAST: including inventor search: please see attached and/or scanned notes/strategy	9/8/2005	JBA
PALM: inventor search	9/8/2005	JBA
STN: medline, caplus, biosis, embase: including inventor search: please see attached and/or scanned notes/strategy:	9/9/2005	JBA